#### 捷多邦,专**SN54ABTH25245**加**SNF4**ABTH25245 25-Ω OCTAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

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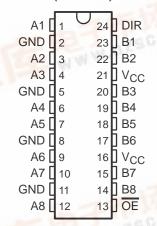
- State-of-the-Art EPIC-IIB™ BiCMOS Design
  Significantly Reduces Power Dissipation
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Typical V<sub>OLP</sub> (Output Ground Bounce) < 1 V at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C
- High-Impedance State During Power Up and Power Down
- Designed to Facilitate Incident-Wave Switching for Line Impedances of 25 Ω or Greater
- Distributed V<sub>CC</sub> and GND Pin Configuration Minimizes High-Speed Switching Noise
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Package Options Include Plastic Small-Outline (DW) Package, Ceramic Chip Carriers (FK), and Standard Plastic (NT) and Ceramic (JT) DIPs

#### description

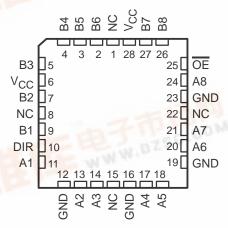
The 'ABTH25245 are  $25-\Omega$  octal bus transceivers designed for asynchronous communication between data buses. They improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented transceivers.

These devices allow noninverted data transmission from the A bus to the B bus or from the B bus to the A bus, depending on the logic level at the direction-control (DIR) input. The output-enable  $(\overline{OE})$  input can disable the device so that both buses are effectively isolated. When  $\overline{OE}$  is low, the device is active.

SN54ABTH25245 ... JT PACKAGE SN74ABTH25245 ... DW OR NT PACKAGE (TOP VIEW)



SN54ABTH25245 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

These transceivers are capable of sinking 188 mA of  $I_{OL}$  current, which facilitates switching 25- $\Omega$  transmission lines on the incident wave. The distributed  $V_{CC}$  and GND pins minimize switching noise for more-reliable system operation.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.



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#### description (continued)

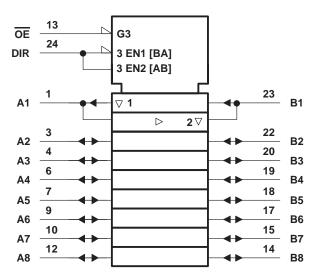
When  $V_{CC}$  is between 0 and 2.1 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 2.1 V,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54ABTH25245 is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to  $125^{\circ}$ C. The SN74ABTH25245 is characterized for operation from  $-40^{\circ}$ C to  $85^{\circ}$ C.

#### **FUNCTION TABLE**

INP	UTS	OPERATION			
OE	DIR	OPERATION			
L	L	B data to A bus			
L	Н	A data to B bus			
Н	Χ	Isolation			

#### logic symbol†



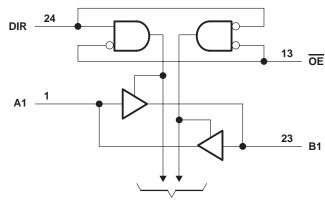
<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the DW, JT, and NT packages.



#### SN54ABTH25245, SN74ABTH25245 25-Ω OCTAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

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#### logic diagram (positive logic)



To Seven Other Channels

Pin numbers shown are for the DW, JT, and NT packages.

#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage range, V <sub>CC</sub>	0.5 V to 7 V
Input voltage range, V <sub>I</sub> (except I/O ports) (see Note 1)	0.5 V to 7 V
Voltage range applied to any output in the disabled or power-off state, V <sub>O</sub>	0.5 V to 5.5 V
Voltage range applied to any output in the high state, V <sub>O</sub>	0.5 V to V <sub>CC</sub>
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	–18 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)	–50 mA
Current into any output in the low state, IO: SN74ABTH25245 (A port)	376 mA
SN74ABTH25245 (B port)	128 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 2): DW package	81°C/W
NT package	67°C/W
Storage temperature range, Teta	. −65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

<sup>2.</sup> The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51, except for through-hole packages, which use a trace length of zero.

### SN54ABTH25245, SN74ABTH25245 25- $\Omega$ OCTAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS SCBS251F – JUNE 1992 – REVISED MAY 1997

#### recommended operating conditions (see Note 3)

				SN54ABTI	H25245	SN74ABTH25245		UNIT	
				MIN	MAX	MIN	MAX	UNIT	
Vcc	Supply voltage				5.5	4.5	5.5	V	
VIH	High-level input voltage			2		2		V	
V <sub>IL</sub>	Low-level input voltage				0.8		8.0	V	
٧ <sub>I</sub>	Input voltage				Vcc	0	VCC	V	
ΙΙΚ	Input clamp current				-18		-18	mA	
lou	IOH High-level output current		A port	40	-80		-80	mA	
IOH			B port	-32			-32	IIIA	
lou	la. Lauria de la compania		A port	20	188		188	mA	
lOL	Low-level output current	B port	000	64		64			
Δt/Δν	Input transition rise or fall rate	Outputs enabled	Control inputs	Q	4		4	ns/V	
ΔυΔν	Input transition rise or fall rate Outputs er		A or B ports		10		10	115/ V	
Δt/ΔV <sub>CC</sub>	Power-up ramp rate			200		200	·	μs/V	
TA	Operating free-air temperature			-55	125	-40	85	°C	

NOTE 3: Unused control pins must be held high or low to prevent them from floating.

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### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS			SN54ABTH25245			SN74ABTH25245			
PAI	KAMETER	TEST CONDITIONS			TYP†	MAX	MIN	TYP†	MAX	UNIT	
٧ıK		$V_{CC} = 4.5 \text{ V},$	$I_{ } = -18 \text{ mA}$			-1.2			-1.2	V	
	A port	$V_{CC} = 4.75 \text{ V},$	$I_{OH} = -3 \text{ mA}$	2.7			2.7				
		$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -80 \text{ mA}$	2.4			2.4				
Vон		$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -3 \text{ mA}$	2.5			2.5			V	
	B port	$V_{CC} = 5 V$ ,	$I_{OH} = -3 \text{ mA}$	3			3				
		$V_{CC} = 4.5 \text{ V},$	$I_{OH} = -32 \text{ mA}$	2*			2				
	A port	V <sub>CC</sub> = 4.5 V	$I_{OL} = 94 \text{ mA}$			0.55			0.55		
VOL	VOL .	VCC = 4.5 V	I <sub>OL</sub> = 188 mA			0.7			0.7	V	
	B port	$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 64 \text{ mA}$			0.55*			0.55		
V <sub>hys</sub>	_				100			100		mV	
l <sub>I</sub>	Control inputs	$V_{CC} = 0 \text{ to } 5.5 \text{ V},$	$V_I = V_{CC}$ or GND			£ £1			±1	μΑ	
''	A or B ports	$V_{CC} = 2.1 \text{ V to } 5.5 \text{ V},$	$V_I = V_{CC}$ or GND		<u>ک</u>	±20			±20	μΑ	
lizi i.iv	A or B ports	V <sub>CC</sub> = 4.5 V	V <sub>I</sub> = 0.8 V	100	Q.		100			μА	
<sup>I</sup> I(hold)		VCC = 4.5 V	V <sub>I</sub> = 2 V	-100	-100		-100			μιτ	
lozpu <sup>‡</sup>	:	$V_{CC} = 0 \text{ to } 2.1 \text{ V}, V_{O} =$	$0.5 \text{ V to } 2.7 \text{ V}, \overline{\text{OE}} = X$	4	3	±50			±50	μΑ	
lozpd <sup>‡</sup>		$V_{CC} = 2.1 \text{ V to } 0, V_{O} =$	0.5 V to 2.7 V, $\overline{\sf OE}$ = X	0	)	±50			±50	μΑ	
l <sub>off</sub>		$V_{CC} = 0$ ,	$V_I$ or $V_O \le 4.5 \text{ V}$	Q		±100			±100	μΑ	
ICEX		$V_{CC} = 5.5 \text{ V},$	V <sub>O</sub> = 5.5 V			50			50	μΑ	
ΙΟ <sup>§</sup>	B port	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.5 V	-50		-210	-50		-210	mA	
		V <sub>CC</sub> = 5.5 V,	Outputs high			500			500	μΑ	
ICC		Outputs open,	Outputs low			20			20	mA	
		$V_I = V_{CC}$ or GND	Outputs disabled			500			500	μΑ	
ΔICC¶		$V_{CC} = 5.5 \text{ V}$ , One input Other inputs at $V_{CC}$ or 0				1			1	mA	
Ci	Control inputs	V <sub>CC</sub> = 5 V,	V <sub>I</sub> = V <sub>CC</sub> or GND		4			4		pF	
C <sub>io</sub>	A or B ports	V <sub>CC</sub> = 5 V,	$V_O = V_{CC}$ or GND		11.5			11.5		pF	

 $<sup>\</sup>buildrel ^{\star}$  On products compliant to MIL-PRF-38535, this parameter does not apply.



<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

<sup>&</sup>lt;sup>‡</sup> This parameter is characterized, but not production tested.

<sup>§</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

 $<sup>\</sup>P$  This is the increase in supply current for each input that is at the specified TTL voltage level rather than  $V_{CC}$  or GND.

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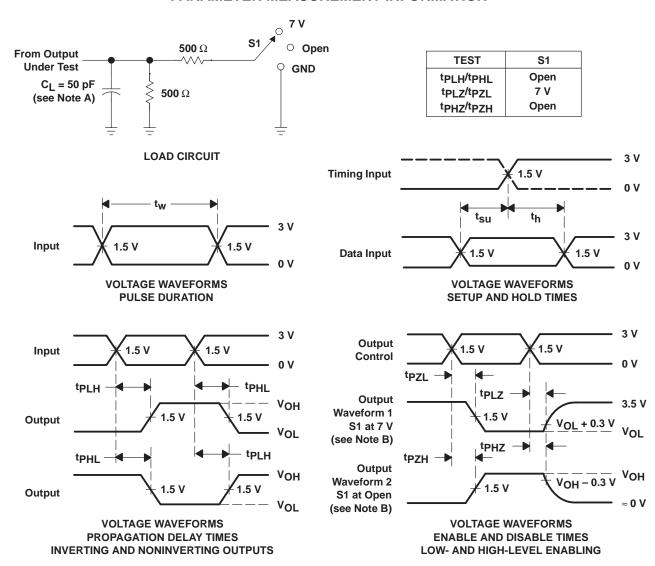
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switching characteristics over recommended ranges of supply voltage and operating free-air temperature,  $C_L$  = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C			SN54ABTH25245	SN74ABTH25245		UNIT	
			MIN	TYP	MAX	MIN MAX	MIN	MAX		
<sup>t</sup> PLH	A or B	B or A	1	2.3	3.5	1 🕺	1	3.9	ne	
<sup>t</sup> PHL			1	2.4	3.5	1 &	1	4.3	ns	
<sup>t</sup> PZH	ŌĒ	A or B	1.5	3.7	5.4	1.5	1.5	6.5		
<sup>t</sup> PZL			1.4	4	5.8	1.4	1.4	6.8	ns	
<sup>t</sup> PHZ	ŌĒ	A or B	2	4.3	6.1	0 2	2	7.2	ns	
tPLZ			2	3.9	5.8	2 2	2	6.4		

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#### PARAMETER MEASUREMENT INFORMATION



NOTES: A.  $C_L$  includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_Q = 50 \Omega$ ,  $t_f \leq 2.5 \text{ ns.}$
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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